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APPLICANT Yasuji MIZUTANI et al.

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						YES	NO
AL	4 3 2 80 64	A 11/17/92	Japan				X
AM	5 71 8 65 71	A 11/17/82	Japan			English Summary	
AN	4 3 1 16 0A	2/3/92	Japan			English Summary	
AO	4 5 15 9 A	11/9/92	Japan			English Summary	
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AL	7 1 7 38 8 A	1/20/95	Japan			English Summary	
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